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# Direct bandgap materials based on the thin films of $\text{Se}_x\text{Te}_{100-x}$ nanoparticles

Numan Salah<sup>1\*</sup>, Sami S Habib<sup>1</sup> and Zishan H Khan<sup>2</sup>**Abstract**

In this study, we fabricated thin films of  $\text{Se}_x\text{Te}_{100-x}$  ( $x=0, 3, 6, 9, 12,$  and  $24$ ) nanoparticles using thermal evaporation technique. The results obtained by X-ray diffraction show that the as-synthesized nanoparticles have polycrystalline structure, but their crystallinity decreases by increasing the concentration of Se. They were found to have direct bandgap ( $E_g$ ), whose value increases by increasing the Se content. These results are completely different than those obtained in the films of  $\text{Se}_x\text{Te}_{100-x}$  microstructure counterparts. Photoluminescence and Raman spectra for these films were also demonstrated. The remarkable results obtained in these nanoparticles specially their controlled direct bandgap might be useful for the development of optical disks and other semiconductor devices.

**Keywords:**  $\text{Se}_x\text{Te}_{100-x}$  Nanoparticles, Direct energy bandgap, Photoluminescence, Raman spectroscopy

**Background**

In the last two decades, much research work is focused on the synthesis and characterization of semiconducting nanomaterials [1]. Among these nanostructures, nanochalcogenides are important materials for various applications such as nanoelectronic devices, nanomemory devices, optical memory devices, etc. Recently, we have produced different nanochalcogenides and studied their structural, optical, and electrical properties [2-7]. However, these studies are still at the early stage and need to be further extended to cover more chalcogenide, that is, due to the primary remarkable results obtained in their nanostructure forms.

Several studies were focused on fabricating different nanostructures of different amorphous alloys/crystalline materials and studying their properties. For example, Tripathi et al. [8] have studied the optical properties of  $\text{Se}_{100-x}\text{Te}_x$  ( $x=4, 8,$  and  $16$ ) nanostructured thin films grown by thermal evaporation. Chawla et al. [9] have synthesized  $\text{Zn}_{1-x}\text{Cd}_x\text{S}:\text{Cu}$  nanoparticles and tuned the bandgap by increasing the Cd content. El-Nahass et al. [10] have studied the influence of heat treatment and gamma ray irradiation on the structural and optical characterizations of nanocrystalline cobalt phthalocyanine thin

films. Gracin et al. [11] have analyzed the amorphous-nanocrystalline multilayer structures by optical, photo-deflection, and photocurrent spectroscopies.

The studies on the preparation and characterization of nanocrystalline thin films are also available in the literature by various workers [12-14]. Keeping in view the scope of nanostructure materials, we have communicated several reports on synthesis and characterization of nanochalcogenides in both the amorphous and crystalline forms by different techniques [2-7]. Therefore, the preparation and characterization of nanochalcogenide materials are extremely important for application in optical devices. This work reports on thin films of  $\text{Se}_x\text{Te}_{100-x}$  ( $x=0, 3, 6, 9, 12,$  and  $24$ ) nanoparticles synthesized using thermal evaporation method. The as-synthesized nanoparticle films were characterized by X-ray diffraction (XRD), scanning electron microscopy (SEM), energy dispersive spectroscopy (EDS), absorption spectrum, photoluminescence (PL), and Raman spectroscopy.

**Methods**

Glassy alloy of  $\text{Se}_x\text{Te}_{100-x}$  ( $x=0, 3, 6, 9, 12,$  and  $24$ ) in powder form have been prepared by the method adopted from Khan et al. [7]. In this method, high purity (99.999%) materials are weighed in appropriate proportions according to their atomic percentages (at.%) and sealed into quartz ampoules under vacuum of about  $10^{-5}$  Torr. The sealed ampoules are then kept in a muffle furnace, where

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the temperature is raised up to 950 K at the rate of 3 K/min. Once the desired temperature of 950 K is reached, the sealed ampoules are kept at this temperature for 14 h with rocking. Through the heating process, ampoules are rotated in clockwise and anticlockwise directions with the help of the motor to ensure homogeneity of the composition within the samples. Once this process is over, the melt is rapidly quenched in ice water to make it amorphous.

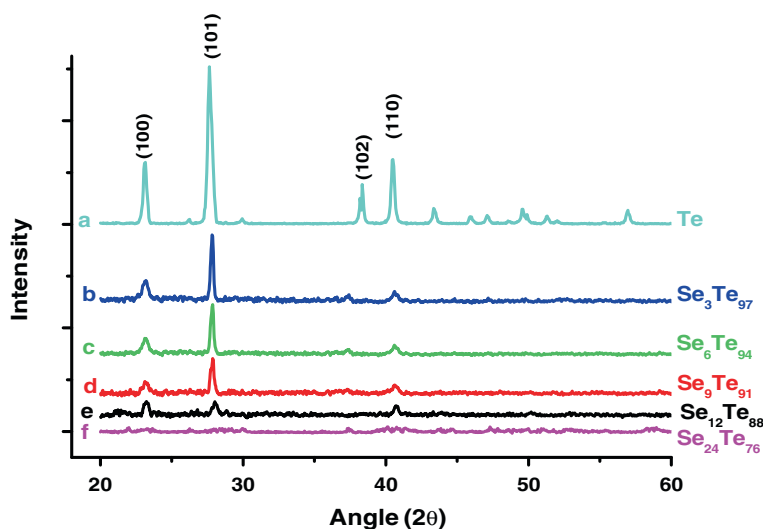
Thin films of  $\text{Se}_x\text{Te}_{100-x}$  ( $x=0, 3, 6, 9, 12,$  and  $24$ ) nanoparticles were fabricated using physical vapor condensation method. Initially, a small quantity of glassy alloy of  $\text{Se}_x\text{Te}_{100-x}$  in powder form is kept in a molybdenum boat, and the chamber is evacuated to a vacuum of the order of  $10^{-6}$  Torr. After reaching this vacuum level, the argon gas is purged inside the chamber. The pressure of the gas was kept constant at 5 Torr. The glassy alloy is then evaporated in the presence of the ambient argon gas atmosphere in the chamber to get the nanostructures. The substrate is cooled with liquid nitrogen, and this evaporated material is deposited on a glass substrate pasted on this cooled substrate. The thicknesses of the films were measured using a quartz crystal monitor Edward model FTM 7 (Edwards BOC, England, UK). The thickness is fixed at 30 nm for all the films. This value was confirmed by the surface profiler AS 500 Tencor AlphaStep (Brumley South, Inc. Mooresville, NC, USA).

The as-synthesized samples were characterized by X-ray diffraction, using an Ultima-IV (Rigaku Corporation, Tokyo, Japan) diffractometer with  $\text{Cu K}\alpha$  radiation, while the morphology of these nanostructures is studied by SEM using Quanta, FEI (Eindhoven, The Netherlands). The chemical compositions of the deposited films were

measured by the EDS technique using EDAX, Ametec. The optical absorption of thin films of  $\text{Se}_x\text{Te}_{100-x}$  ( $x=3, 6, 9,$  and  $12$ ) have been measured by a UV-visible computerized spectrophotometer (model 'UV-1650PC', Shimadzu Corporation, Tokyo, Japan) in the wavelength region of 400 to 1,100 nm. Here, we have kept the samples (films) and reference (glass substrate) in the chamber to neutralize the absorption of glass. The absorption has been measured in terms of optical density. The optical absorption is measured as a function of incidence photon energy. PL emission spectra for the thin films of  $\text{Se}_x\text{Te}_{100-x}$  were recorded at room temperature at excitation wavelength of 325 nm using a fluorescence spectrofluorophotometer, model RF-5301 PC, Shimadzu, Japan, while Raman spectra were measured using DXR Raman microscope, Thermo Scientific Inc. (Waltham, MA, USA) using the 532-nm laser as excitation source at 6-mW power.

## Results and discussion

XRD patterns of the as-synthesized thin films of  $\text{Se}_x\text{Te}_{100-x}$  ( $x=0, 3, 6, 9, 12,$  and  $24$ ) are presented in Figure 1 (curves a, b, c, d, e, and f). The figure shows few structural diffraction peaks, which might be due to the presence of a mixture of amorphous and crystalline phases. The crystalline phase is found to decrease by increasing the concentration of Se. At the highest concentration of Se (i.e.,  $x=24$ ), the material is completely amorphous (Figure 1f), while that of  $x=0$  (Figure 1a), it has almost crystalline structure. It has been reported by several authors that the XRD pattern of pure Te shows high degree of crystallinity [15,16], while selenium (Se) easily forms amorphous phase [17,18]. This is in agreement with the present result where pure Te shows



**Figure 1** XRD pattern of the as-synthesized thin film of  $\text{Se}_x\text{Te}_{100-x}$  nanoparticles.

crystalline phase, and its alloying with Se reduces the crystallinity of  $\text{Se}_x\text{Te}_{100-x}$  system.

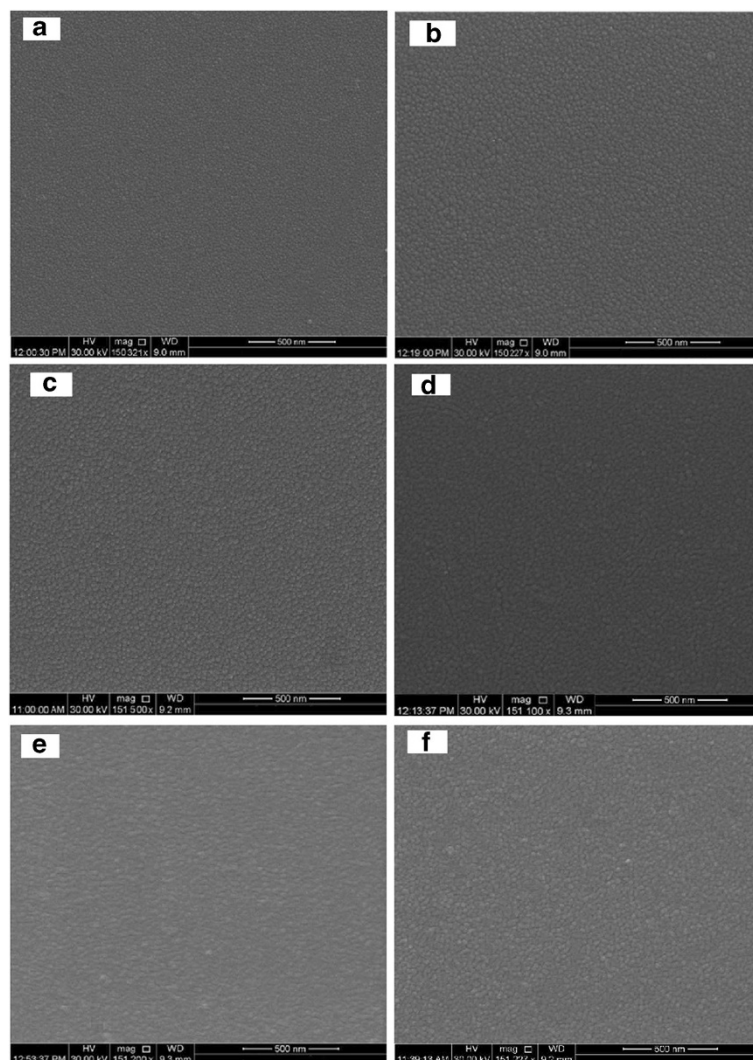
SEM images for the as-synthesized thin films of  $\text{Se}_x\text{Te}_{100-x}$  are presented in Figure 2a,b,c,d,e,f for Te,  $\text{Se}_3\text{Te}_{97}$ ,  $\text{Se}_6\text{Te}_{94}$ ,  $\text{Se}_9\text{Te}_{91}$ ,  $\text{Se}_{12}\text{Te}_{88}$ , and  $\text{Se}_{24}\text{Te}_{76}$ , respectively. Small nanoparticles can be seen in these films with particle size in the range of 15 to 20 nm. The morphology of these nanoparticles is almost similar in all the films. The particle size in pure Te film (Figure 2a) is smaller than those grown in Se-Te films.

The chemical compositions of these films were measured using EDS. Typical results obtained from some of these films are presented in Figure 3A,B,C,D. The EDS results show that the deposited films have compositions close to those of the bulk materials. This figure shows clearly the decrease in Te and increase in Se concentrations.

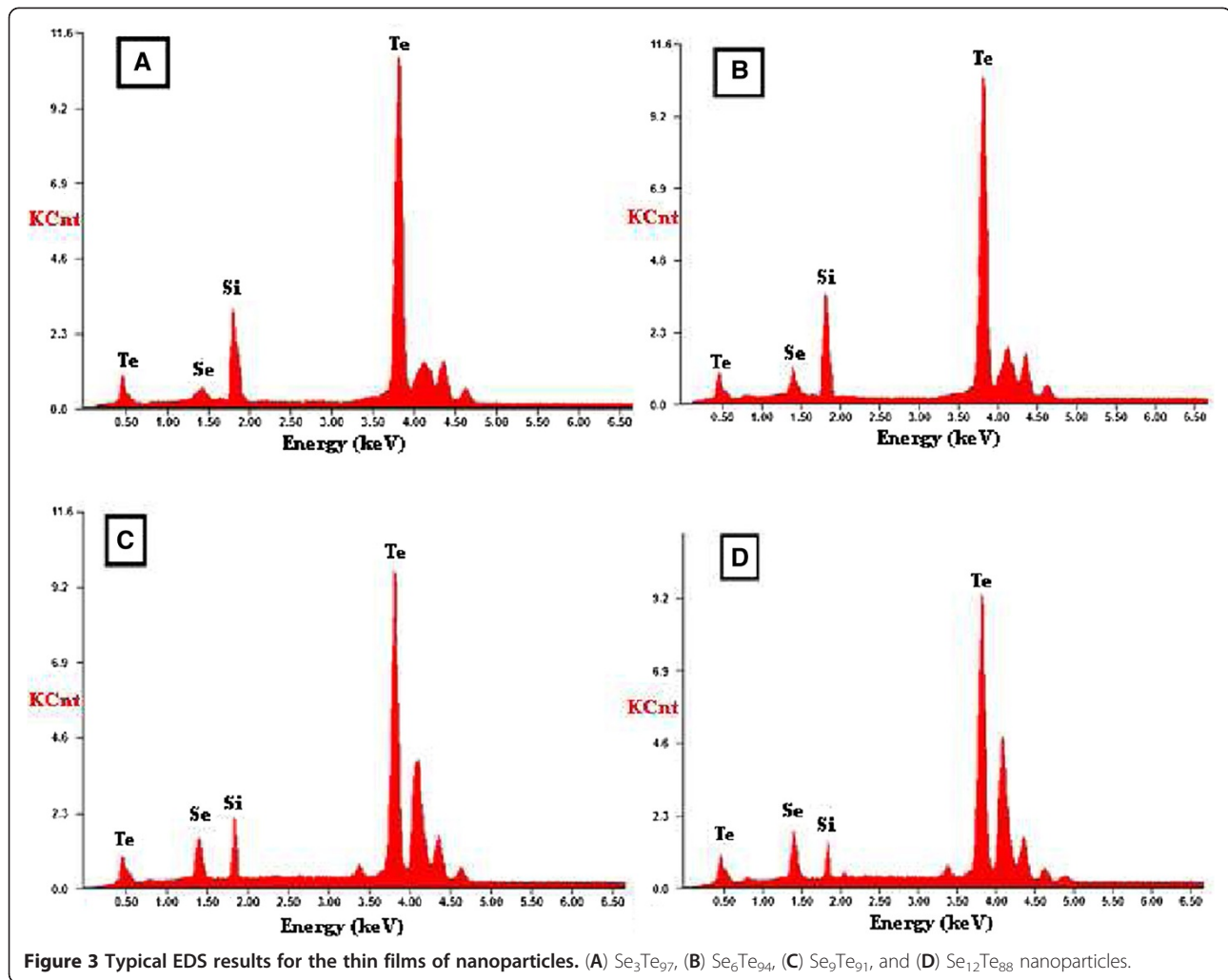
Figure 4a (curves a1, b1, c1, d1, e1, and f1) shows the UV-visible absorption spectra of the as-synthesized thin films of  $\text{Se}_x\text{Te}_{100-x}$  nanoparticles. The curves of Se-Te films show maximum absorption bands at around 520 nm, while that of pure Te has lower absorption around this value. The absorption increases by increasing the concentration of Se. This might be due to the decrease in the crystallinity of the deposited material as could be seen from the XRD results (Figure 1). The value of the absorption coefficient ( $\alpha$ ) has been calculated using the following relation:

$$\alpha = OD/t \quad (1)$$

where OD is the optical density measured at a given layer thickness  $t$ . This  $\alpha$  is used to obtain the energy bandgap ( $E_g$ ) values. The variation of  $\alpha$  with incident photon energy



**Figure 2** SEM images for the thin films of  $\text{Se}_x\text{Te}_{100-x}$  nanoparticles. (a) Te, (b)  $\text{Se}_3\text{Te}_{97}$ , (c)  $\text{Se}_6\text{Te}_{94}$ , (d)  $\text{Se}_9\text{Te}_{91}$ , (e)  $\text{Se}_{12}\text{Te}_{88}$ , and (f)  $\text{Se}_{24}\text{Te}_{76}$ .



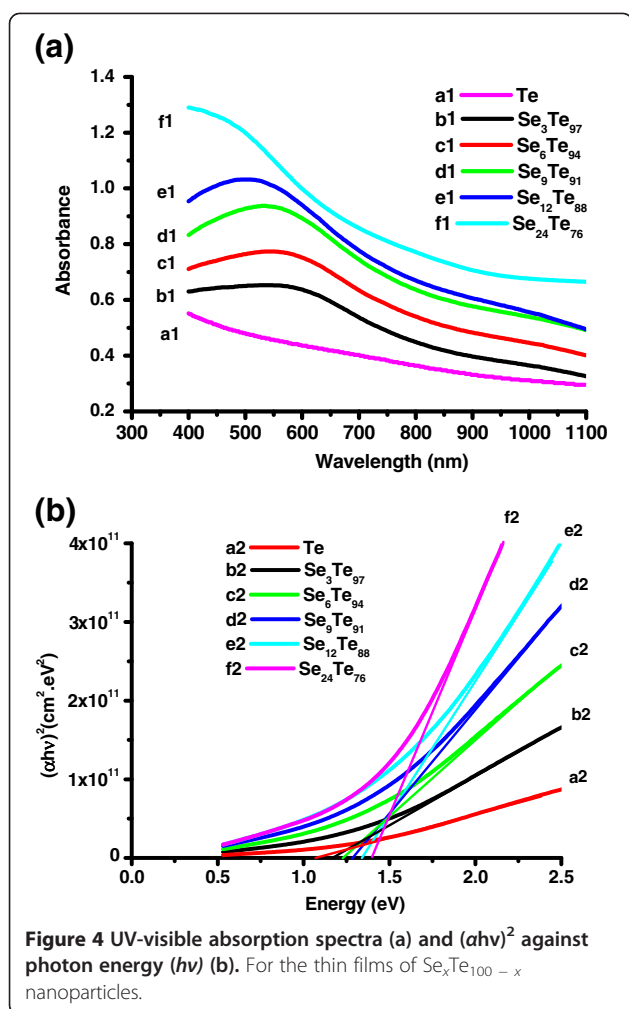
( $h\nu$ ) in the present thin films of  $\text{Se}_x\text{Te}_{100-x}$  nanoparticles was found to obey the rule of direct transition, and the relation between the optical gap, optical absorption coefficient, and the energy  $h\nu$  of the incident photon is given by [7]:

$$(ah\nu)^2 \propto (h\nu - E_g) \quad (2)$$

Figure 4b shows the variation of  $(ah\nu)^2$  with photon energy ( $h\nu$ ) for the thin films of  $\text{Se}_x\text{Te}_{100-x}$  nanoparticles (curves a2, b2, c2, d2, e2, and f2). The value of direct optical bandgap ( $E_g$ ) is calculated by taking the intercept on the  $x$ -axis. The calculated values of  $E_g$  for the thin films of Te,  $\text{Se}_3\text{Te}_{97}$ ,  $\text{Se}_6\text{Te}_{94}$ ,  $\text{Se}_9\text{Te}_{91}$ ,  $\text{Se}_{12}\text{Te}_{88}$ , and  $\text{Se}_{24}\text{Te}_{76}$  are 1.08, 1.17, 1.22, 1.28, 1.34, and 1.39 eV, respectively. It is clear that there is a significant increase in the value of the optical bandgap by increasing the Se concentration in this system. These values are comparable with those of  $\text{Se}_x\text{Te}_{100-x}$  microsize alloys presented by Khan et al. [7]. These films of  $\text{Se}_x\text{Te}_{100-x}$  microsize

particles were reported to have indirect bandgaps with values decreasing by increasing the concentration of Se [7]. They have attributed this decrease to the increase of the localized states in the amorphous systems due to Se addition.

In the present nanoscale materials, if we compare the results presented by Khan et al. [7] with our findings, it is clear that their microsize materials are completely of amorphous nature, which is not the case in the present nanomaterials. The thin films of  $\text{Se}_x\text{Te}_{100-x}$  nanoparticles have a considerable amount of crystalline phase (Figure 1) that might have lesser concentration of localized states (lower density of localized states than those at the microsize). These localized states induced in the band structure of  $\text{Se}_x\text{Te}_{100-x}$  nanoparticles might have reorganized their positions during the nanoparticle growth, result in a formation of direct band gap. These reorganized localized states of lower density might also be responsible for the increase in values of the bandgap by adding Se to the host. It means that at the nanoscale



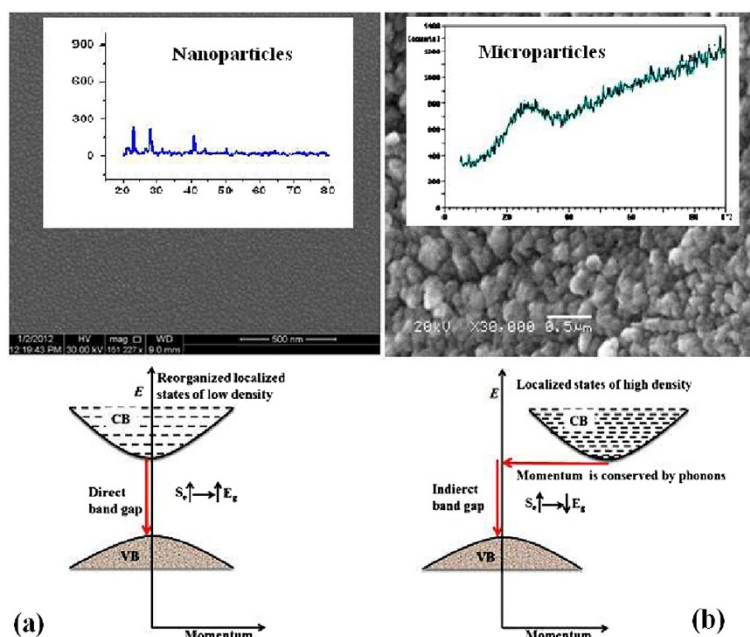
level, particularly at sizes closer to quantum dots, the energy levels might arrange themselves to have direct bandgap. Further addition of dopants (defects/localized states) to the host could increase the value of this bandgap. These behaviors are completely different than those of the microsize particles. These illustrations are presented in Figure 5. This figure shows clearly the direct and indirect bandgaps formed in the nano- and microsize particles of the thin films of  $\text{Se}_x\text{Te}_{100-x}$  (Figure 5a, b, respectively). The figure also shows the conduction bands in both cases, which have different densities of localized states due to the crystallinity present in these structures. Typical SEM images and XRD results of these nano- and microsize particles are also shown in Figure 5 (SEM image and XRD result of the microsize particles are obtained from [7]).

Tripathi et al. [8] synthesized nanostructures of selenium-rich samples ( $\text{Se}_{100-x}\text{Te}_x$ ,  $x=4, 8, 16$ ) in the presence of oxygen and argon, but their results show indirect bandgap in their nanoparticle films (their particle size is in the range of 40 to 100 nm). This might be due

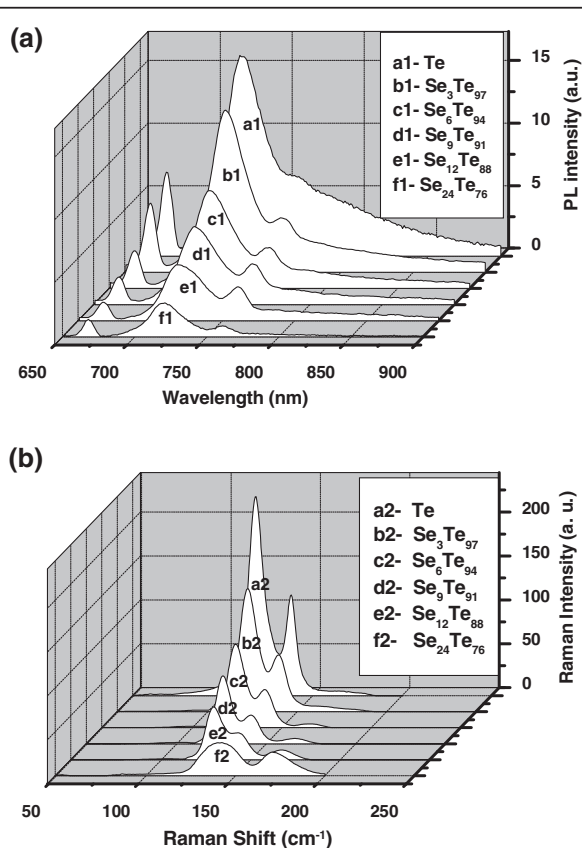
to the size of their nanoparticles, which is much bigger than that of the quantum dots. The other possibility is that tellurium atom (0.140 nm) as dopants, which is bigger than Se atom (0.115 nm), could not induce defects/localized states that have the ability to arrange themselves to provide direct bandgap. In the present case, it is the remarkable results for tellurium-rich compounds in nanostructure form to have direct bandgaps. This might be attributed to the reorganization and modifications induced in positions of the localized states of the nanostructure materials as explained above.

Since the optical absorption depends on short-range order in the amorphous states and defects associated with it, the change in optical bandgap of the films of microsize particles of  $\text{Se}_x\text{Te}_{100-x}$  was explained by Khan et al. [7] on the basis of 'density of state model' proposed by Mott and Davis [19]. According to this model, the width of the localized states near the mobility edges depends on the degree of disorder and defects present in the amorphous structure. In particular, it is known that unsaturated bonds together with some saturated bonds are produced as the result of an insufficient number of atoms deposited in the amorphous film [20]. The unsaturated bonds are responsible for the formation of some of the defects in the films, producing localized/defect states in the amorphous solids. However, this model [19] has not taken into consideration the effect of particle size on these localized states. In addition to this model, it is expected that at the nanoscale level these localized/defect states might have reorganized their positions in the band structure, resulting in the formation of direct bandgap (Figure 5). Crystal field effect might be another factor affecting the localized states formed in the nanoparticles, which might be smaller than that of the microsize particles, resulting in the widening of the bandgap. This increase in optical bandgap may also be due to the shift in Fermi level whose position is determined by the distribution of electrons over the localized states [21].

PL emission spectra for the as-synthesized thin films of  $\text{Se}_x\text{Te}_{100-x}$  nanoparticles are presented in Figure 6a (curves a1, b1, c1, d1, e1, and f1). These films were excited by 325 nm. Three emission bands are observed at around 666, 718, and 760 nm in these films. The second band at 718 nm is over two times stronger than those at 666 and 760 nm. These bands are observed in the PL spectra of all the films deposited at different values of  $x$ . The only change that could be observed by increasing the concentration of Se is a reduction in the intensities of these bands. The intensities of these bands were significantly decreased by increasing the dopant concentration. The PL emission spectrum is similar to those observed in single crystals of GaTe reported by several authors [22-24]. It is therefore possible that the



**Figure 5** Schematic band structure of  $\text{Se}_x\text{Te}_{100-x}$  (a) nano- and (b) microsize particles. SEM and XRD results of the microsize particles are obtained from [9].



**Figure 6** Photoluminescence emission spectra (a) and (b) Raman spectra. Of the thin films of  $\text{Se}_x\text{Te}_{100-x}$  nanoparticles.

origin of these bands mainly the first and second bands is similar to those observed in the single crystal of GaTe, which are the recombination of direct free excitons (radiative annihilation of free excitons) and the impurity levels (such as residual impurity, defects, or defect complexes) localized in the forbidden energy gap. The second band at 718 nm might be attributed to the recombination of direct free excitons [22,23], while that at 666 nm might be ascribed to the impurity levels localized in the forbidden energy gap. The third band at 760 nm may be due to the recombination of direct free excitons at the surface of the grown nanoparticles. The intensities of these bands might have a direct link to the degree of crystallinity. In the present alloy, it is possible that the recombination of some of the free excitons becomes non-radiative by going from crystalline to amorphous phase. This might be the reason for the PL quenching. Moreover, it is quite possible that there might be a recombination of free excitons located at the adjacent nanoparticles. Electrons in one nanoparticle might have recombined with the holes of the next nanoparticle. In this case, the flux or the density of the emitted photons might be lower than those in the case of single crystals. This might also result in PL quenching.

Raman spectra of the thin films of  $\text{Se}_x\text{Te}_{100-x}$  nanoparticles are presented in Figure 6b (curves a2, b2, c2, d2, e2, and f2). The most noticeable features in the Raman spectra of these films are the three bands observed at around 123, 143, and 169  $\text{cm}^{-1}$ . The first band at 123  $\text{cm}^{-1}$  is the most prominent one. Intensities

of the first two bands are observed to decrease by increasing the concentration of Se, while it is vice versa for the band observed at  $169\text{ cm}^{-1}$ . The band at  $123\text{ cm}^{-1}$  might be assigned to the  $A_1$  mode corresponding to symmetric stretching of a triangle of three Te atoms [25,26], while that at  $143\text{ cm}^{-1}$  might be ascribed to the amorphous Te-Te stretching mode [27,28]. The later one has also been assigned to t-Se crystals [29]. The band at around  $169\text{ cm}^{-1}$  might be assigned to the Se-Se bonds [30]. The intensity of this band is significantly increased by increasing the concentration of Se. These results show that the progressive introduction of selenium to the structure of tellurium in the alloys of  $\text{S}_x\text{Te}_{100-x}$  induces the breaking of Te-Te bonds (especially those of the crystalline phase). These results are consistent with those of the XRD (Figure 1). The most intense band at  $123\text{ cm}^{-1}$  is significantly reduced by adding Se as a result of decreasing the crystallinity of the system.

From the application point of view, the obtained results in the present tellurium rich nanomaterials ( $\text{S}_x\text{Te}_{100-x}$ ,  $x=0, 3, 6, 9, 12, \text{ and } 24$ ) are remarkable. The results show the controlled direct bandgap, which might be useful for different applications. This direct bandgap gives more favorable optoelectronic properties than the indirect bandgap [31]. Direct bandgap means that electrons at the minimum of the conduction band have the same momentum as electrons at the maximum of the valence band, and for an indirect bandgap, the electrons do not have the same momentum. The recombination of an electron near the bottom of the conduction band with a hole near the top of the valence band requires the exchange of energy and momentum. For indirect bandgap recombination, the energy may be carried off by a photon, but one or more phonons are required to conserve momentum (Figure 5). This multi-particle interaction is improbable, and the recombination efficiency in the indirect bandgap material is lower than that in the case of direct bandgap material. The majority part of semiconductors is indirect bandgap material; compared with them, direct bandgap materials are preferred for several applications such as laser diodes. Direct bandgap structures maximize the tendency of electrons and holes to recombine by stimulated emission, thus increasing the laser efficiency. Moreover, the material with controlled bandgap (by increasing the concentration of Se in the present nanomaterial) expected to have better properties. They can be alloyed to ternary and quaternary compositions, with adjustable bandgap width. Here in the present nanomaterials, i.e.,  $\text{S}_x\text{Te}_{100-x}$ , there are no changes in positions of the emitted wavelengths (Figure 6a) due to changing the bandgap values. The only change that could be observed is the intensity of these emissions. Thus, controlling the intensity of these emissions might be useful in optoelectronic devices.

Furthermore, providing materials with wide bandgaps allows operation of power devices at higher temperatures and gives lower thermal noise to low-power devices at room temperature [32].

## Conclusions

Thin films of  $\text{S}_x\text{Te}_{100-x}$  ( $x=0, 3, 6, 9, 12, \text{ and } 24$ ) nanoparticles with particle size in the range of 15 to 20 nm have been synthesized using thermal evaporation technique. The as-grown nanoparticles have polycrystalline structure, but their crystallinity decreases by increasing the concentration of Se. These nanomaterials are found to have direct bandgap, which differ from their microstructure counterparts. Moreover, this bandgap could be tuned by changing the concentration of Se. PL emission spectra for these films showed three bands at 666, 718, and 760 nm, while Raman spectra display three bands at 123, 143, and  $169\text{ cm}^{-1}$ . The intensities of PL and Raman bands were decreased by increasing the concentration of Se except that of the last band of Raman wherein it is increased. These results might be useful for the development of optical disks and other semiconducting devices based on these controlled direct bandgap nanomaterials.

## Competing interests

The authors declare that they have no competing interests.

## Authors' contributions

All authors equally contributed in writing the manuscript and in performing the experiments. All authors read and approved the final manuscript.

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